

<b>Notice of References Cited</b>	Application/Control No. 10/660,756		Applicant(s)/Patent Under Reexamination YAMADA ET AL.	
	Examiner Raymond S. Dean		Art Unit 2618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,150,384	09-1992	Cahill, Stephen V.	375/375
*	B	US-7,065,333	06-2006	Engstrom, G. Eric	455/184.1
*	C	US-2002/0013143	01-2002	Lee et al.	455/412
*	D	US-7,054,660	05-2006	Lord, Frank H.	455/558
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11136202 A	05-1999	Japan	NARITA, SHOICHI	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.